Search Notes					

Application/Control No.	Applicant(s)/Patent under Reexamination		
10/705,238	JANG ET AL.		
Examiner	Art Unit		
Matthew G. Kayrish	2627		

SEARCHED					
Class	Subclass	Date	Examiner		
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INTERFERENCE SEARCHED						
Subclass	Date	Examiner				
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		Subclass Date				

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
EAST (Search History Attached)	9/26/2007	MK		
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